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### The Transistor, A Semi-Conductor Triode

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A THREE-ELEMENT electronic device which utilizes a newly discovered principle involving a semi-conductor as the basic element is described. It may be employed as an amplifier, oscillator, and for other purposes for which vacuum tubes are ordinarily used. The device consists of three electrodes placed on a block of germanium<sup>1</sup> as shown schematically in Fig. 1. Two, called the emitter and collector, are of the point-contact rectifier type and are placed in close proximity (separation  $\sim .005$  to  $.025$  cm) on the upper surface. The third is a large area low resistance contact on the base.

The germanium is prepared in the same way as that used for high back-voltage rectifiers.<sup>2</sup> In this form it is an *N*-type or excess semi-conductor with a resistivity of the order of 10 ohm cm. In the original studies, the upper surface was subjected to an additional anodic oxidation in a glycol borate solution<sup>3</sup> after it had been ground and etched in the usual way. The oxide is washed off and plays no direct role. It has since been found that other surface treatments are equally effective. Both tungsten and phosphor bronze points have been used. The collector point may be electrically formed by passing large currents in the reverse direction.

Each point, when connected separately with the base electrode, has characteristics similar to those of the high

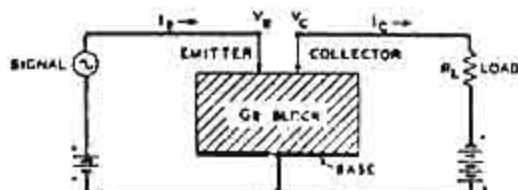


FIG. 1. Schematic of semi-conductor triode.

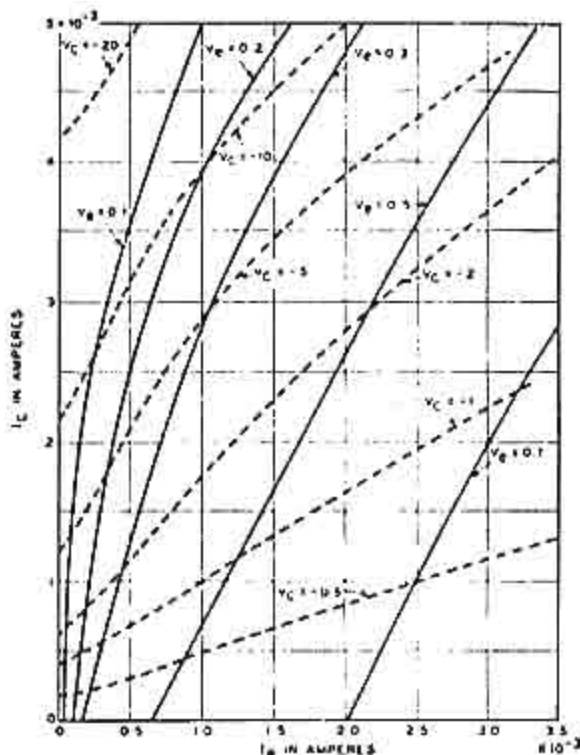


FIG. 2. d.c. characteristics of an experimental semi-conductor triode. The currents and voltages are as indicated in Fig. 1.

back-voltage rectifier. Of critical importance for the operation of the device is the nature of the current in the forward direction. We believe, for reasons discussed in detail in the accompanying letter,<sup>4</sup> that there is a thin layer next to the surface of *P*-type (defect) conductivity. As a result, the current in the forward direction with respect to the block is composed in large part of holes, i.e., of carriers of sign opposite to those normally in excess in the body of the block.

When the two point contacts are placed close together on the surface and d.c. bias potentials are applied, there is a mutual influence which makes it possible to use the device to amplify a.c. signals. A circuit by which this may be accomplished is shown in Fig. 1. There is a small forward (positive) bias on the emitter, which causes a current of a few milliamperes to flow into the surface. A reverse (negative) bias is applied to the collector, large enough to make the collector current of the same order or greater than the emitter current. The sign of the collector bias is such as to attract the holes which flow from the emitter so that a large part of the emitter current flows to and enters the collector. While the collector has a high impedance for flow of electrons into the semi-conductor, there is little impediment to the flow of holes into the point. If now the emitter current is varied by a signal voltage, there will be a corresponding variation in collector current. It has been found that the flow of holes from the emitter into the collector may alter the normal current flow from the base to the collector in such a way that the change in collector

current is larger than the change in emitter current. Furthermore, the collector, being operated in the reverse direction as a rectifier, has a high impedance ( $10^4$  to  $10^6$  ohms) and may be matched to a high impedance load. A large ratio of output to input voltage, of the same order as the ratio of the reverse to the forward impedance of the point, is obtained. There is a corresponding power amplification of the input signal.

The d.c. characteristics of a typical experimental unit are shown in Fig. 2. There are four variables, two currents and two voltages, with a functional relation between them. If two are specified the other two are determined. In the plot of Fig. 2 the emitter and collector currents  $I_e$  and  $I_c$  are taken as the independent variables and the corresponding voltages,  $V_e$  and  $V_c$ , measured relative to the base electrode, as the dependent variables. The conventional directions for the currents are as shown in Fig. 1. In normal operation,  $I_e$ ,  $I_c$ , and  $V_e$  are positive, and  $V_c$  is negative.

The emitter current,  $I_e$ , is simply related to  $V_e$  and  $I_c$ . To a close approximation:

$$I_e = f(V_e + R_F I_c), \quad (1)$$

where  $R_F$  is a constant independent of bias. The interpretation is that the collector current lowers the potential of the surface in the vicinity of the emitter by  $R_F I_c$ , and thus increases the effective bias voltage on the emitter by an equivalent amount. The term  $R_F I_c$  represents a positive feedback, which under some operating conditions is sufficient to cause instability.

The current amplification factor  $\alpha$  is defined as

$$\alpha = (\partial I_c / \partial I_e)_{V_c = \text{const.}}$$

This factor depends on the operating biases. For the unit shown in Fig. 2,  $\alpha$  lies between one and two if  $V_e < -2$ .

Using the circuit of Fig. 1, power gains of over 20 db have been obtained. Units have been operated as amplifiers at frequencies up to 10 megacycles.

We wish to acknowledge our debt to W. Shockley for initiating and directing the research program that led to the discovery on which this development is based. We are also indebted to many other of our colleagues at these Laboratories for material assistance and valuable suggestions.

<sup>1</sup> While the effect has been found with both silicon and germanium, we describe only the use of the latter.

<sup>2</sup> The germanium was furnished by J. H. Scaff and H. C. Theuerer. For methods of preparation and information on the rectifier, see H. C. Torrey and C. A. Whitmer, *Crystal Rectifiers* (McGraw-Hill Book Company, Inc., New York, New York, 1948), Chap. 12.

<sup>3</sup> This surface treatment is due to R. B. Gibney, formerly of Bell Telephone Laboratories, now at Los Alamos Scientific Laboratory.

<sup>4</sup> W. H. Brattain and J. Bardeen, *Phys. Rev.*, this issue.